

# RF Power Field Effect Transistors

## N-Channel Enhancement-Mode Lateral MOSFETs

Designed for W-CDMA and LTE base station applications with frequencies from 750 to 820 MHz. Can be used in Class AB and Class C for all typical cellular base station modulation formats.

- Typical Single-Carrier W-CDMA Performance:  $V_{DD} = 28$  Volts,  $I_{DQ} = 2000$  mA,  $P_{out} = 96$  Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF.

| Frequency | $G_{ps}$ (dB) | $\eta_D$ (%) | Output PAR (dB) | ACPR (dBc) |
|-----------|---------------|--------------|-----------------|------------|
| 790 MHz   | 20.9          | 35.2         | 6.2             | -38.1      |
| 805 MHz   | 21.0          | 35.5         | 6.2             | -38.1      |
| 820 MHz   | 20.9          | 35.7         | 6.1             | -38.2      |

- Capable of Handling 10:1 VSWR, @ 32 Vdc, 805 MHz, 500 Watts CW Output Power (3 dB Input Overdrive from Rated  $P_{out}$ ), Designed for Enhanced Ruggedness
- Typical  $P_{out}$  @ 1 dB Compression Point  $\approx$  340 Watts CW

### Features

- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Series Equivalent Large-Signal Impedance Parameters and Common Source S-Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Designed for Digital Predistortion Error Correction Systems
- Optimized for Doherty Applications
- In Tape and Reel. R6 Suffix = 150 Units, 56 mm Tape Width, 13-inch Reel.

**Table 1. Maximum Ratings**

| Rating                               | Symbol    | Value       | Unit        |
|--------------------------------------|-----------|-------------|-------------|
| Drain-Source Voltage                 | $V_{DSS}$ | -0.5, +70   | Vdc         |
| Gate-Source Voltage                  | $V_{GS}$  | -6.0, +10   | Vdc         |
| Operating Voltage                    | $V_{DD}$  | 32, +0      | Vdc         |
| Storage Temperature Range            | $T_{stg}$ | -65 to +150 | $^{\circ}C$ |
| Case Operating Temperature           | $T_C$     | 150         | $^{\circ}C$ |
| Operating Junction Temperature (1,2) | $T_J$     | 225         | $^{\circ}C$ |

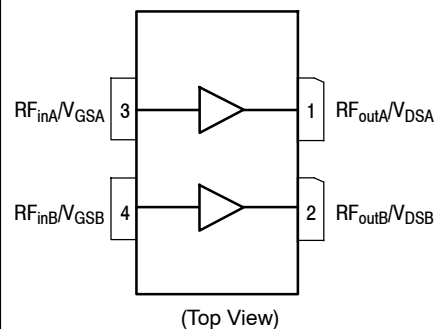
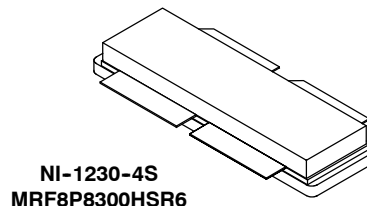
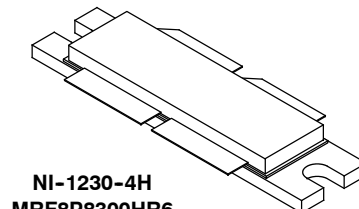
**Table 2. Thermal Characteristics**

| Characteristic  | Symbol          | Value (2,3)  | Unit          |
|---|-----------------|--------------|---------------|
| Thermal Resistance, Junction to Case<br>Case Temperature 80 $^{\circ}C$ , 96 W CW, 28 Vdc, $I_{DQ} = 2000$ mA, 820 MHz<br>Case Temperature 85 $^{\circ}C$ , 300 W CW, 28 Vdc, $I_{DQ} = 2000$ mA, 820 MHz | $R_{\theta JC}$ | 0.26<br>0.21 | $^{\circ}C/W$ |

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.

**MRF8P8300HR6**  
**MRF8P8300HSR6**

**750-820 MHz, 96 W AVG., 28 V**  
**SINGLE W-CDMA**  
**LATERAL N-CHANNEL**  
**RF POWER MOSFETs**



**Figure 1. Pin Connections**

**Table 3. ESD Protection Characteristics**

| Test Methodology                      | Class |
|---------------------------------------|-------|
| Human Body Model (per JESD22-A114)    | 2     |
| Machine Model (per EIA/JESD22-A115)   | A     |
| Charge Device Model (per JESD22-C101) | IV    |

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted)

| Characteristic  | Symbol    | Min | Typ | Max | Unit            |
|---|-----------|-----|-----|-----|-----------------|
| <b>Off Characteristics</b> <sup>(1)</sup>   |           |     |     |     |                 |
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 70\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | —   | —   | 10  | $\mu\text{Adc}$ |
| Zero Gate Voltage Drain Leakage Current<br>( $V_{DS} = 28\text{ Vdc}$ , $V_{GS} = 0\text{ Vdc}$ ) | $I_{DSS}$ | —   | —   | 1   | $\mu\text{Adc}$ |
| Gate-Source Leakage Current<br>( $V_{GS} = 5\text{ Vdc}$ , $V_{DS} = 0\text{ Vdc}$ )              | $I_{GSS}$ | —   | —   | 1   | $\mu\text{Adc}$ |

**On Characteristics**

|   |              |     |     |     |     |
|---|--------------|-----|-----|-----|-----|
| Gate Threshold Voltage <sup>(1)</sup><br>( $V_{DS} = 10\text{ Vdc}$ , $I_D = 400\ \mu\text{Adc}$ )              | $V_{GS(th)}$ | 1.5 | 2.3 | 3.0 | Vdc |
| Gate Quiescent Voltage<br>( $V_{DD} = 28\text{ Vdc}$ , $I_{DQ} = 2000\text{ mA}$ , Measured in Functional Test) | $V_{GS(Q)}$  | 2.3 | 3.1 | 3.8 | Vdc |
| Drain-Source On-Voltage <sup>(1)</sup><br>( $V_{GS} = 10\text{ Vdc}$ , $I_D = 3\text{ Adc}$ )                   | $V_{DS(on)}$ | 0.1 | 0.2 | 0.3 | Vdc |

**Functional Tests** <sup>(2)</sup> (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ} = 2000\text{ mA}$ ,  $P_{out} = 96\text{ W Avg.}$ ,  $f = 820\text{ MHz}$ , Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @  $\pm 5\text{ MHz}$  Offset.

|  |          |      |       |       |     |
|--|----------|------|-------|-------|-----|
| Power Gain   | $G_{ps}$ | 20.0 | 20.9  | 23.5  | dB  |
| Drain Efficiency   | $\eta_D$ | 34.5 | 35.7  | —     | %   |
| Output Peak-to-Average Ratio @ 0.01% Probability on CCDF | PAR      | 5.9  | 6.1   | —     | dB  |
| Adjacent Channel Power Ratio                             | ACPR     | —    | -38.2 | -36.5 | dBc |
| Input Return Loss  | IRL      | —    | -12   | -9    | dB  |

**Typical Performance over Frequency** (In Freescale Test Fixture, 50 ohm system)  $V_{DD} = 28\text{ Vdc}$ ,  $I_{DQ} = 2000\text{ mA}$ ,  $P_{out} = 96\text{ W Avg.}$ , Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 7.5 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @  $\pm 5\text{ MHz}$  Offset.

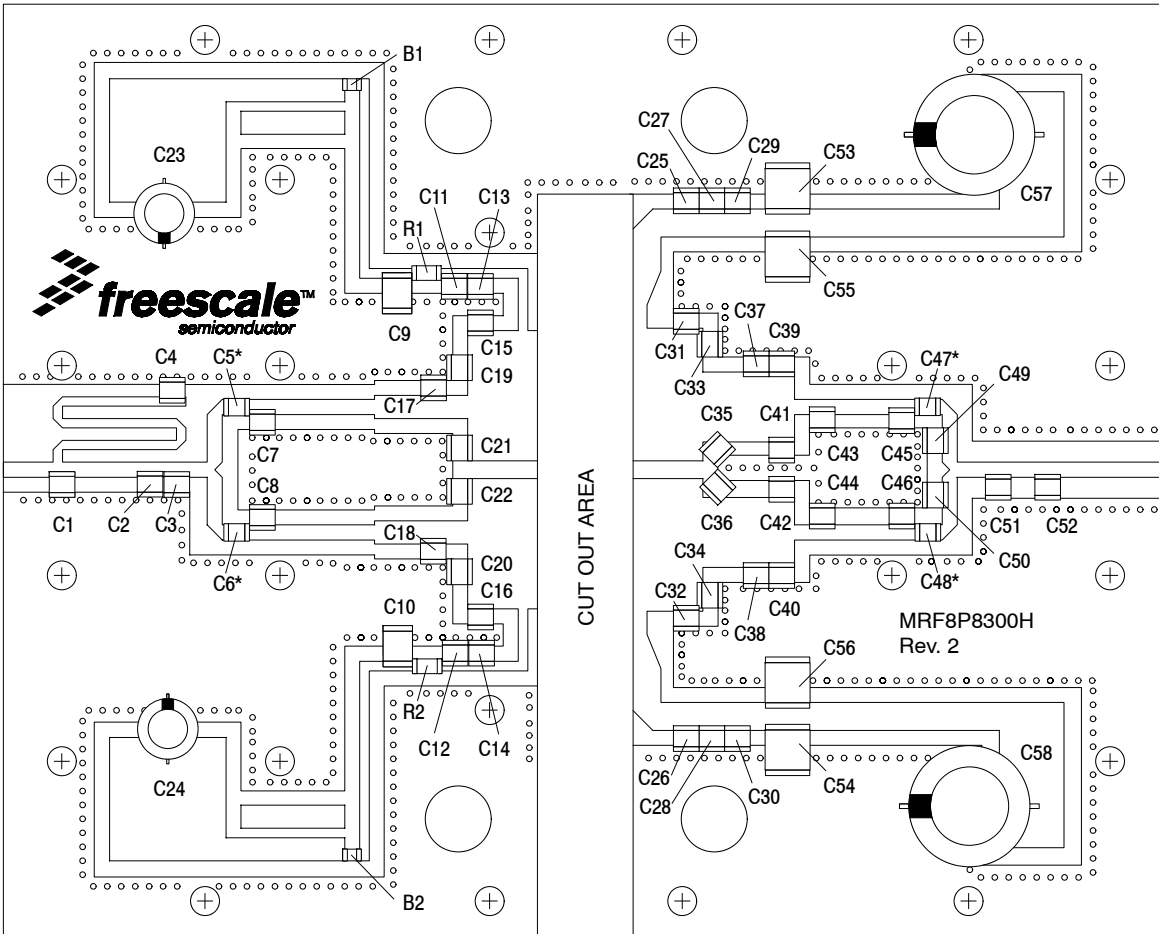
| Frequency | $G_{ps}$<br>(dB) | $\eta_D$<br>(%) | Output PAR<br>(dB) | ACPR<br>(dBc) | IRL<br>(dB) |
|-----------|------------------|-----------------|--------------------|---------------|-------------|
| 790 MHz   | 20.9             | 35.2            | 6.2                | -38.1         | -11         |
| 805 MHz   | 21.0             | 35.5            | 6.2                | -38.1         | -12         |
| 820 MHz   | 20.9             | 35.7            | 6.1                | -38.2         | -12         |

1. Each side of device measured separately.
2. Part internally matched both on input and output.

(continued)

**Table 4. Electrical Characteristics** ( $T_A = 25^\circ\text{C}$  unless otherwise noted) (continued)

| Characteristic  | Symbol           | Min | Typ    | Max | Unit                 |
|---|------------------|-----|--------|-----|----------------------|
| <b>Typical Performances</b> (In Freescale Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$ , $I_{DQ} = 2000\text{ mA}$ , 790–820 MHz Bandwidth   |                  |     |        |     |                      |
| $P_{out}$ @ 1 dB Compression Point, CW  | $P_{1dB}$        | —   | 340    | —   | W                    |
| IMD Symmetry @ 290 W PEP, $P_{out}$ where IMD Third Order Intermodulation $\cong 30\text{ dBc}$<br>(Delta IMD Third Order Intermodulation between Upper and Lower Sidebands $> 2\text{ dB}$ ) | $IMD_{sym}$      | —   | 35     | —   | MHz                  |
| VBW Resonance Point<br>(IMD Third Order Intermodulation Inflection Point)   | $VBW_{res}$      | —   | 35     | —   | MHz                  |
| Gain Flatness in 30 MHz Bandwidth @ $P_{out} = 96\text{ W Avg.}$  | $G_F$            | —   | 0.5    | —   | dB                   |
| Gain Variation over Temperature<br>( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )   | $\Delta G$       | —   | 0.0185 | —   | dB/ $^\circ\text{C}$ |
| Output Power Variation over Temperature<br>( $-30^\circ\text{C}$ to $+85^\circ\text{C}$ )   | $\Delta P_{1dB}$ | —   | 0.0076 | —   | dB/ $^\circ\text{C}$ |



\*C5, C6, C47, and C48 are mounted vertically.

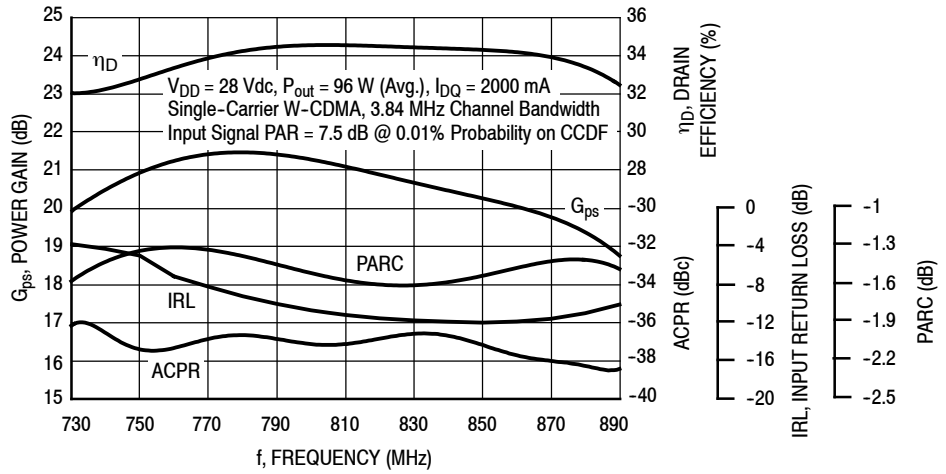
**Figure 2. MRF8P8300HR6(HSR6) Test Circuit Component Layout**

**Table 5. MRF8P8300HR6(HSR6) Test Circuit Component Designations and Values**

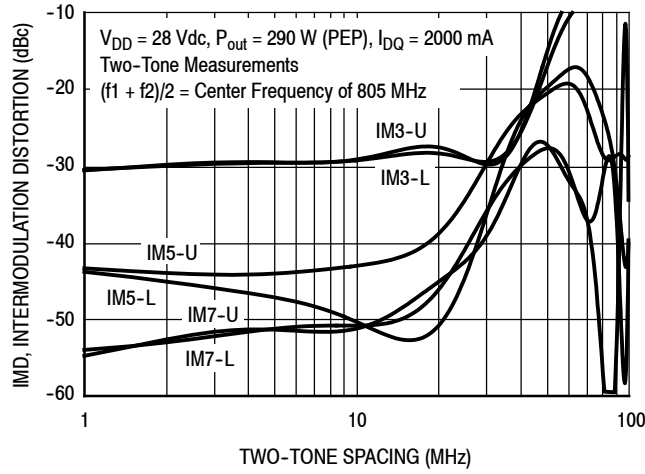
| Part                         | Description                               | Part Number          | Manufacturer |
|------------------------------|---|----------------------|--------------|
| B1, B2                       | Short Ferrite Beads                       | MPZ2012S300AT000     | TDK          |
| C1, C2, C39, C40, C41, C42   | 2.1 pF Chip Capacitors                    | ATC100B2R1BT500XT    | ATC          |
| C3, C49, C50                 | 1.0 pF Chip Capacitors                    | ATC100B1R0BT500XT    | ATC          |
| C4                           | 120 pF Chip Capacitor                     | ATC100B121JT500XT    | ATC          |
| C5, C6, C11, C12, C47, C48   | 39 pF Chip Capacitors                     | ATC100B390JT500XT    | ATC          |
| C7, C8, C45, C46             | 1.1 pF Chip Capacitors                    | ATC100B1R1BT500XT    | ATC          |
| C9, C10                      | 4.7 $\mu$ F, 50 V Chip Capacitors         | C4532X5R1H475KT      | TDK          |
| C13, C14, C19, C20, C25, C26 | 10 pF Chip Capacitors                     | ATC100B100JT500XT    | ATC          |
| C15, C16, C35, C36           | 4.7 pF Chip Capacitors                    | ATC100B4R7CT500XT    | ATC          |
| C17, C18                     | 4.3 pF Chip Capacitors                    | ATC100B4R3CT500XT    | ATC          |
| C21, C22                     | 8.2 pF Chip Capacitors                    | ATC100B8R2CT500XT    | ATC          |
| C23, C24                     | 22 $\mu$ F Electrolytic Capacitors        | UUD1V220MCL1GS       | Nichicon     |
| C27, C28                     | 20 pF Chip Capacitors                     | ATC100B200JT500XT    | ATC          |
| C29, C30                     | 30 pF Chip Capacitors                     | ATC100B300JT500XT    | ATC          |
| C31, C32                     | 13 pF Chip Capacitors                     | ATC100B130JT500XT    | ATC          |
| C33, C34                     | 7.5 pF Chip Capacitors                    | ATC100B7R5CT500XT    | ATC          |
| C37, C38                     | 1.5 pF Chip Capacitors                    | ATC100B1R5BT500XT    | ATC          |
| C43, C44                     | 0.8 pF Chip Capacitors                    | ATC100B0R8BT500XT    | ATC          |
| C51, C52                     | 2.0 pF Chip Capacitors                    | ATC100B2R0BT500XT    | ATC          |
| C53, C54, C55, C56           | 22 $\mu$ F, 50 V Chip Capacitors          | C5750JF1H226ZT       | TDK          |
| C57, C58                     | 470 $\mu$ F, 63 V Electrolytic Capacitors | MCGPR63V477M13X26-RH | Multicomp    |
| R1, R2                       | 3 $\Omega$ Chip Resistors                 | CRCW12063R00FNEA     | Vishay       |
| PCB                          | 0.030", $\epsilon_r = 3.5$                | RF35A2               | Taconic      |

**MRF8P8300HR6 MRF8P8300HSR6**

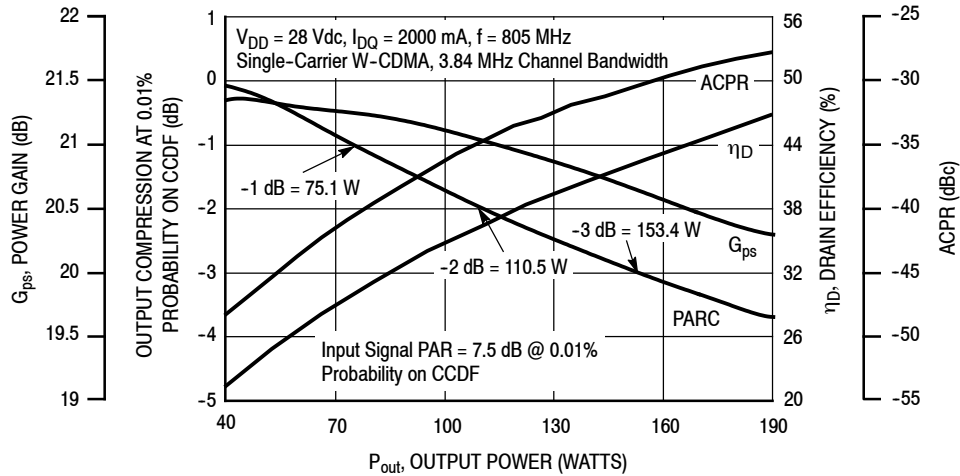
### TYPICAL CHARACTERISTICS



**Figure 3. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @  $P_{out} = 96$  Watts Avg.**

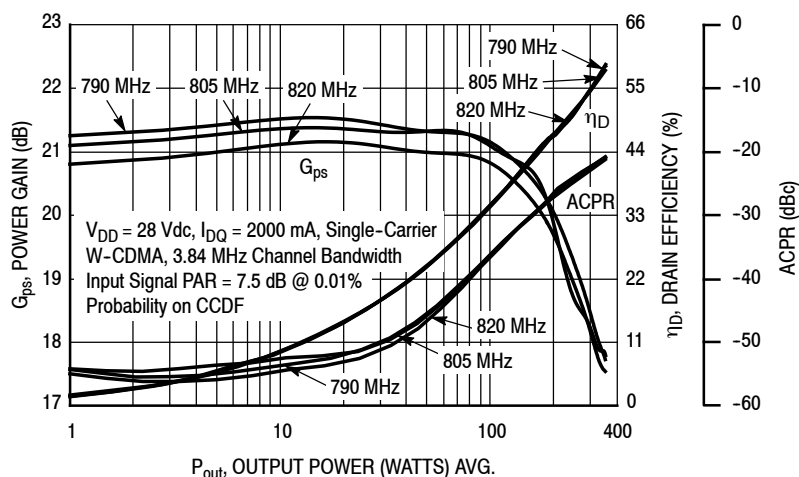


**Figure 4. Intermodulation Distortion Products versus Two-Tone Spacing**

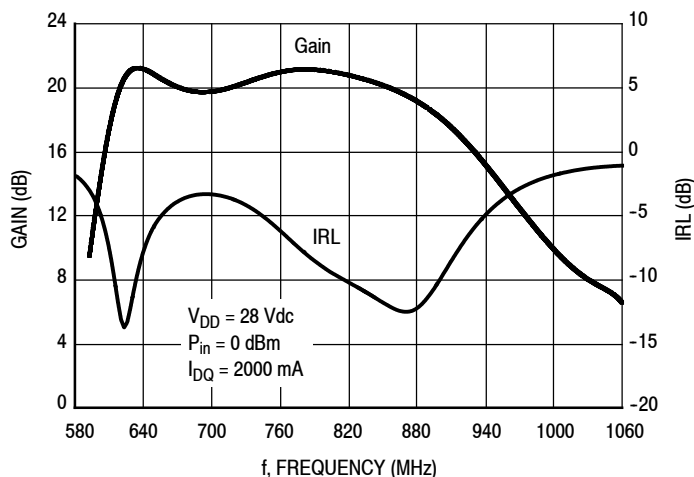


**Figure 5. Output Peak-to-Average Ratio Compression (PARC) versus Output Power**

## TYPICAL CHARACTERISTICS

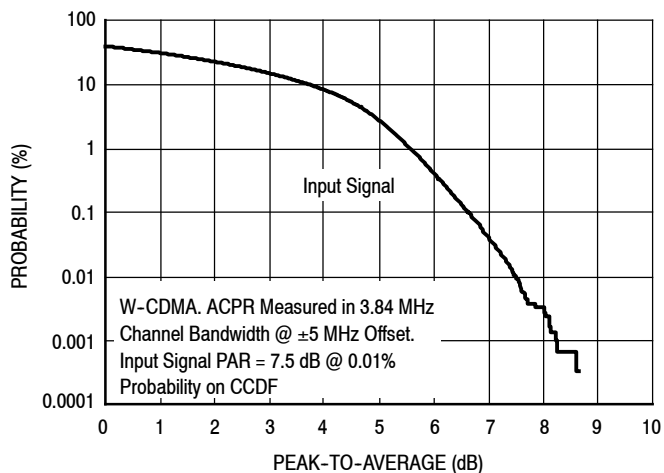


**Figure 6. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power**

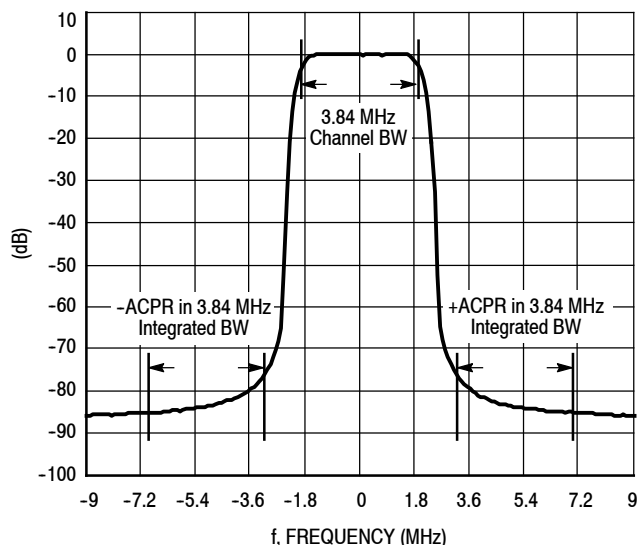


**Figure 7. Broadband Frequency Response**

## W-CDMA TEST SIGNAL



**Figure 8. CCDF W-CDMA IQ Magnitude Clipping, Single-Carrier Test Signal**



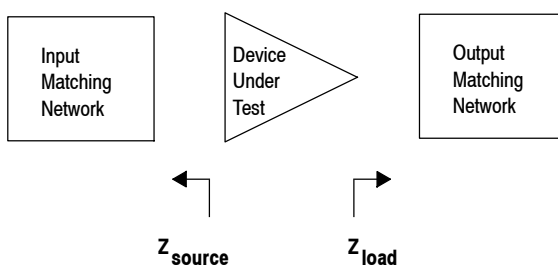
**Figure 9. Single-Carrier W-CDMA Spectrum**

$V_{DD} = 28 \text{ Vdc}$ ,  $I_{DQ} = 2000 \text{ mA}$ ,  $P_{out} = 96 \text{ W Avg.}$

| f<br>MHz | $Z_{source}$<br>$\Omega$ | $Z_{load}$<br>$\Omega$ |
|----------|--------------------------|------------------------|
| 730      | $1.07 - j1.15$           | $0.86 - j0.18$         |
| 750      | $1.06 - j0.97$           | $0.90 + j0.04$         |
| 770      | $1.11 - j0.78$           | $1.07 + j0.46$         |
| 790      | $1.05 - j0.62$           | $1.28 - j0.67$         |
| 810      | $1.11 - j0.45$           | $0.88 - j0.12$         |
| 830      | $1.19 - j0.26$           | $0.87 + j0.04$         |
| 850      | $1.95 + j0.48$           | $0.82 + j0.05$         |
| 870      | $1.35 - j1.66$           | $0.71 + j0.12$         |
| 890      | $0.95 - j1.07$           | $0.59 + j0.22$         |

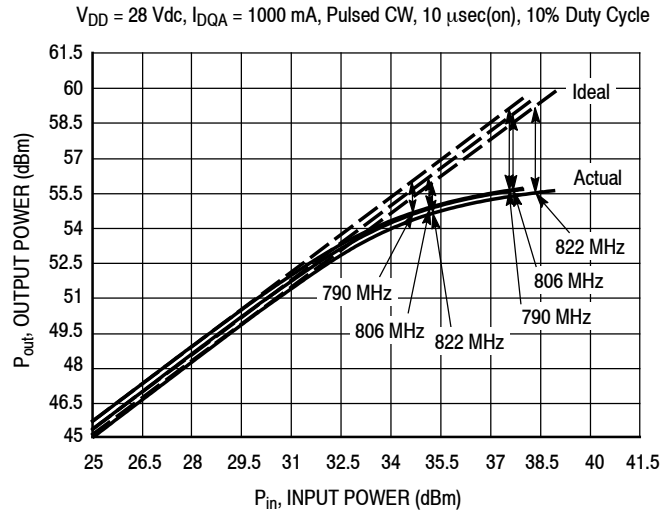
$Z_{source}$  = Test circuit impedance as measured from gate to ground, gate leads are tied together.

$Z_{load}$  = Test circuit impedance as measured from drain to ground, drain leads are tied together.



**Figure 10. Series Equivalent Source and Load Impedance**

## ALTERNATIVE PEAK TUNE LOAD PULL CHARACTERISTICS



NOTE: Load Pull Test Fixture Tuned for Peak P1dB Output Power @ 28 V

| f<br>(MHz) | P1dB  |      | P3dB  |      |
|------------|-------|------|-------|------|
|            | Watts | dBm  | Watts | dBm  |
| 790        | 288   | 54.6 | 363   | 55.6 |
| 806        | 299   | 54.8 | 366   | 55.6 |
| 822        | 287   | 54.6 | 349   | 55.4 |

Test Impedances per Compression Level

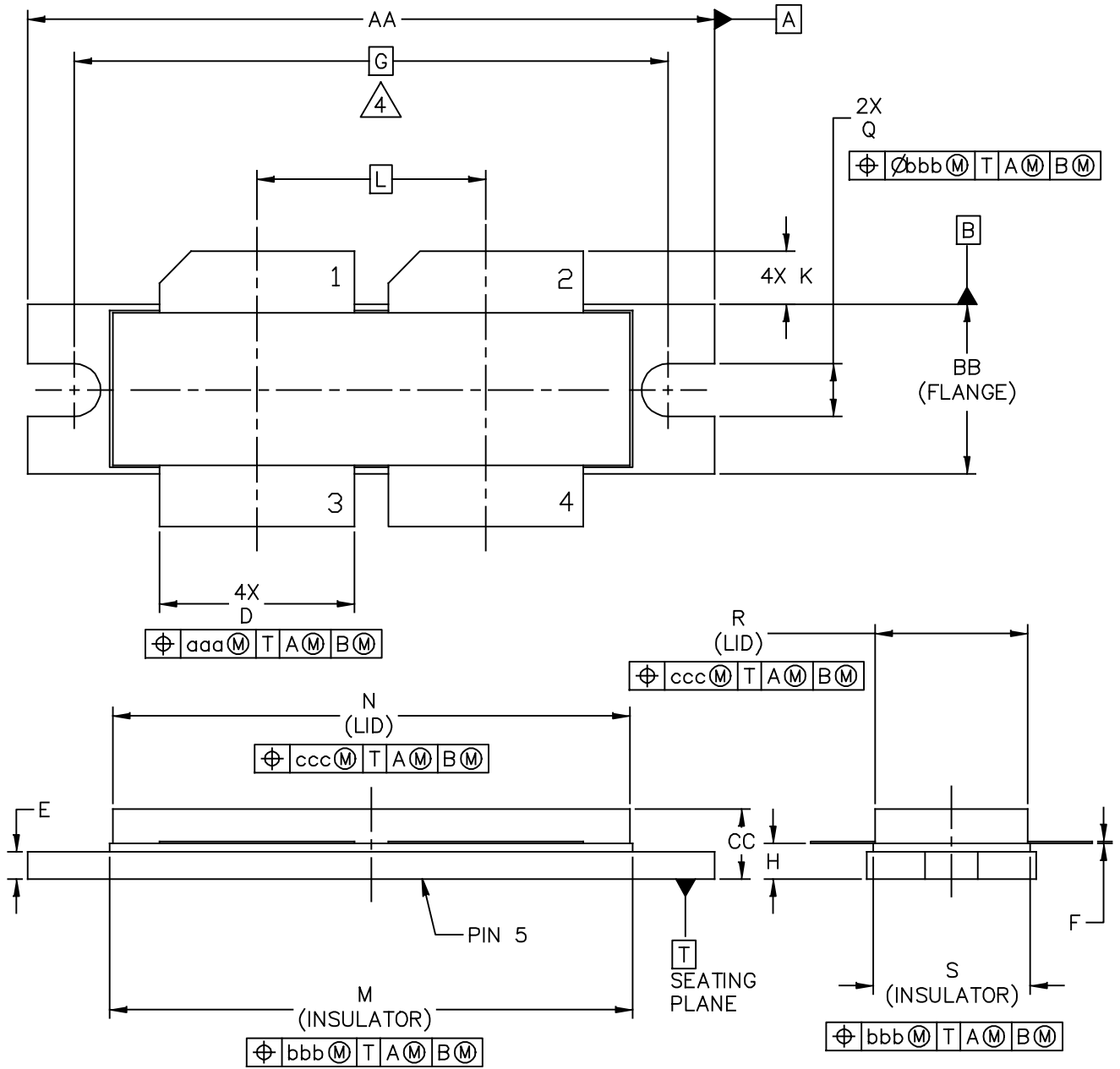
| f<br>(MHz) |      | $Z_{\text{source}}$<br>$\Omega$ | $Z_{\text{load}}$<br>$\Omega$ |
|------------|------|---------------------------------|-------------------------------|
| 790        | P1dB | 1.04 - j0.98                    | 0.78 - j0.73                  |
| 806        | P1dB | 1.16 - j1.39                    | 0.76 - j0.71                  |
| 822        | P1dB | 1.24 - j1.73                    | 0.76 - j0.74                  |

**Figure 11. Pulsed CW Output Power versus Input Power @ 28 V**

Note: Measurement made on a per side basis.



### PACKAGE DIMENSIONS



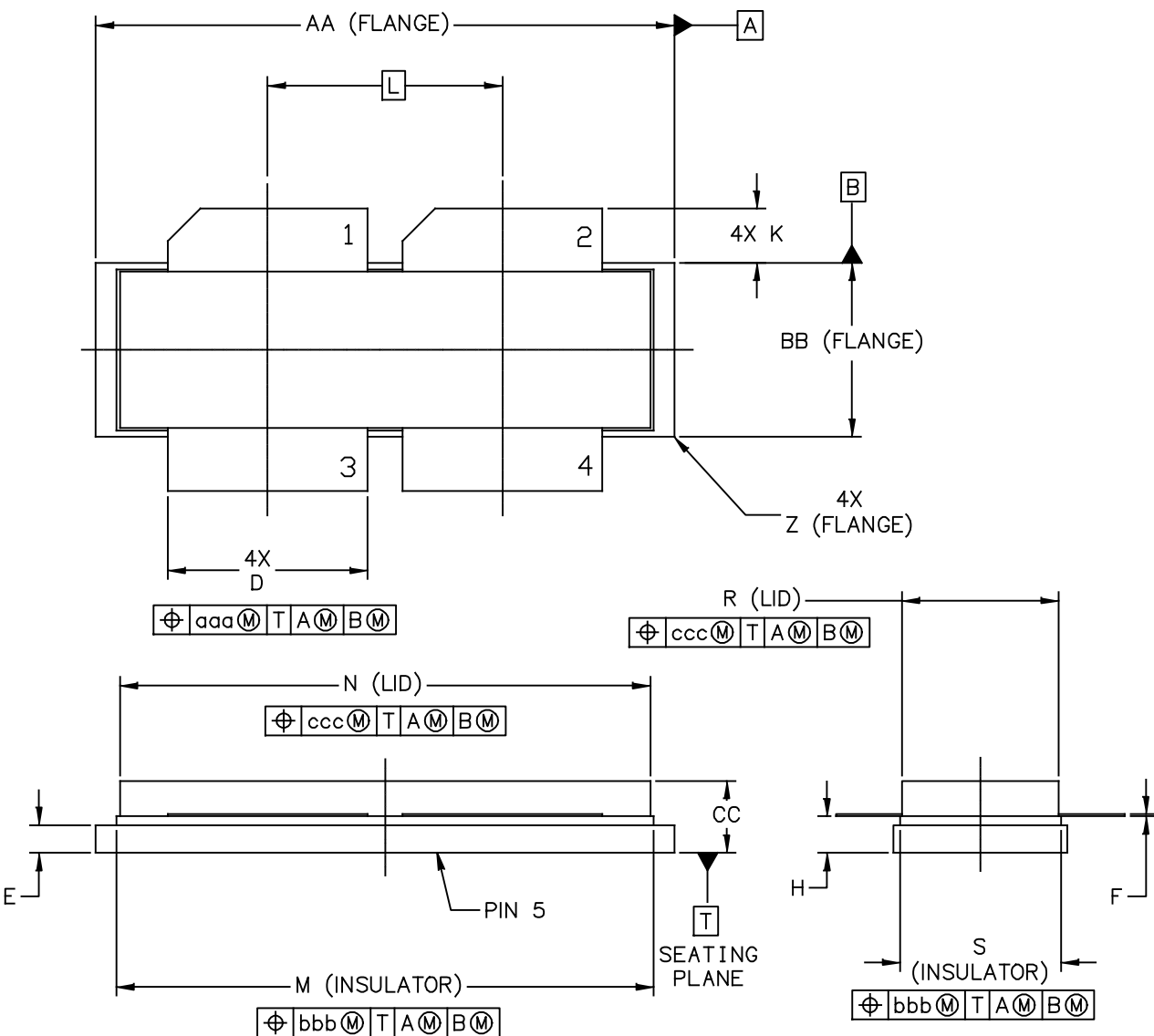
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| TITLE:<br><br>NI-1230-4H                                | DOCUMENT NO: 98ASB16977C | REV: F                     |
|   | STANDARD: NON-JEDEC      |                            |
|   | 28 FEB 2013              |                            |

NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH
3. DIMENSION H IS MEASURED .030 INCH (0.762 MM) AWAY FROM PACKAGE BODY.

4. RECOMMENDED BOLT CENTER DIMENSION OF 1.52 INCH (38.61 MM) BASED ON M3 SCREW.

| DIM   | INCH      |       | MILLIMETER         |       | DIM                                  | INCH                       |       | MILLIMETER |       |
|---|-----------|-------|--------------------|-------|--------------------------------------|----------------------------|-------|------------|-------|
|   | MIN       | MAX   | MIN                | MAX   |                                      | MIN                        | MAX   | MIN        | MAX   |
| AA  | 1.615     | 1.625 | 41.02              | 41.28 | N                                    | 1.218                      | 1.242 | 30.94      | 31.55 |
| BB  | .395      | .405  | 10.03              | 10.29 | Q                                    | .120                       | .130  | 3.05       | 3.30  |
| CC  | .170      | .190  | 4.32               | 4.83  | R                                    | .355                       | .365  | 9.02       | 9.27  |
| D   | .455      | .465  | 11.56              | 11.81 | S                                    | .365                       | .375  | 9.27       | 9.53  |
| E   | .062      | .066  | 1.57               | 1.68  |                                      |                            |       |            |       |
| F   | .004      | .007  | 0.10               | 0.18  |                                      |                            |       |            |       |
| G   | 1.400 BSC |       | 35.56 BSC          |       | aaa                                  | .013                       |       | 0.33       |       |
| H   | .082      | .090  | 2.08               | 2.29  | bbb                                  | .010                       |       | 0.25       |       |
| K   | .117      | .137  | 2.97               | 3.48  | ccc                                  | .020                       |       | 0.51       |       |
| L   | .540 BSC  |       | 13.72 BSC          |       |                                      |                            |       |            |       |
| M   | 1.219     | 1.241 | 30.96              | 31.52 |                                      |                            |       |            |       |
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|   |           |       |                    |       | STANDARD: NON-JEDEC                  |                            |       |            |       |
|   |           |       |                    |       | 28 FEB 2013                          |                            |       |            |       |



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| TITLE:<br><br>NI-1230-4S                                | DOCUMENT NO: 98ARB18247C | REV: G                     |
|   | STANDARD: NON-JEDEC      |                            |
|   | 01 MAR 2013              |                            |

NOTES:

1. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M–1994.
2. CONTROLLING DIMENSION: INCH
3. DIMENSION H IS MEASURED .030 INCH (0.762 MM) AWAY FROM PACKAGE BODY

| DIM   | INCHES   |       | MILLIMETERS        |       | DIM                      | INCHES                     |        | MILLIMETERS |       |
|---|----------|-------|--------------------|-------|--------------------------|----------------------------|--------|-------------|-------|
|   | MIN      | MAX   | MIN                | MAX   |                          | MIN                        | MAX    | MIN         | MAX   |
| AA  | 1.265    | 1.275 | 32.13              | 32.39 | R                        | .355                       | .365   | 9.02        | 9.27  |
| BB  | .395     | .405  | 10.03              | 10.29 | S                        | .365                       | .375   | 9.27        | 9.53  |
| CC  | .170     | .190  | 4.32               | 4.83  | Z                        | R.000                      | R.040  | R0.00       | R1.02 |
| D   | .455     | .465  | 11.56              | 11.81 |                          |                            |        |             |       |
| E   | .062     | .066  | 1.57               | 1.68  | aaa                      | .013                       |        | 0.33        |       |
| F   | .004     | .007  | 0.10               | 0.18  | bbb                      | .010                       |        | 0.25        |       |
| H   | .082     | .090  | 2.08               | 2.29  | ccc                      | .020                       |        | 0.51        |       |
| K   | .117     | .137  | 2.97               | 3.48  |                          |                            |        |             |       |
| L   | .540 BSC |       | 13.72 BSC          |       |                          |                            |        |             |       |
| M   | 1.219    | 1.241 | 30.96              | 31.52 |                          |                            |        |             |       |
| N   | 1.218    | 1.242 | 30.94              | 31.55 |                          |                            |        |             |       |
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| TITLE:<br><br>NI-1230-4S                                |          |       |                    |       | DOCUMENT NO: 98ARB18247C |                            | REV: G |             |       |
|   |          |       |                    |       | STANDARD: NON-JEDEC      |                            |        |             |       |
|   |          |       |                    |       | 01 MAR 2013              |                            |        |             |       |

## PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following documents, tools and software to aid your design process.

### Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

### Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

### Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software and Tools, do a Part Number search at <http://www.freescale.com>, and select the "Part Number" link. Go to the Software & Tools tab on the part's Product Summary page to download the respective tool.

## REVISION HISTORY

The following table summarizes revisions to this document.

| Revision | Date      | Description   |
|----------|-----------|---|
| 0        | Jan. 2011 | <ul style="list-style-type: none"> <li>• Initial Release of Data Sheet</li> </ul>   |
| 1        | Apr. 2013 | <ul style="list-style-type: none"> <li>• Changed operating frequency from 790–820 MHz to 750–820 MHz due to expanded device frequency capability resulting from additional test data, p. 1</li> <li>• Table 3, ESD Protection Characteristics, removed the word "Minimum" after the ESD class rating. ESD ratings are characterized during new product development but are not 100% tested during production. ESD ratings provided in the data sheet are intended to be used as a guideline when handling ESD sensitive devices, p. 2</li> <li>• Replaced Case Outline 98ASB16977C, Issue E with Issue F, p. 9, 10. Changed dimension C from 0.150"–0.200" to CC 0.170"–0.190".</li> <li>• Replaced Case Outline 98ARB18247C, Issue F with Issue G, p. 11, 12. Changed dimension C from 0.150"–0.200" to CC 0.170"–0.190". Added minimum Z dimension R0.00".</li> </ul> |

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